T-46-07-11

National Semiconductor

54ACQ/74ACQ573 • 54ACTQ/74ACTQ573
Quiet Series Octal Latch with TRI-STATE® Outputs

General Description

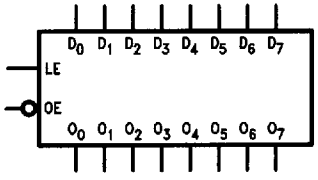
The 'ACQ/'ACTQ573 is a high-speed octal latch with buffered common Latch Enable (LE) and buffered common Output Enable ($\overline{OE}$) inputs. The 'ACQ/'ACTQ573 is functionally identical to the 'ACQ/'ACTQ373 but with inputs and outputs on opposite sides of the package. The 'ACQ/'ACTQ utilizes NSC Quiet Series technology to guarantee quiet output switching and improved dynamic threshold performance. FACT Quiet Series™ features GTO™ output control and undershoot corrector in addition to a split ground bus for superior performance.

Features

- I_{CC} and I_{OZ} reduced by 50%
- Guaranteed simultaneous switching noise level and dynamic threshold performance
- Guaranteed pin-to-pin skew AC performance
- Improved latch-up immunity
- Inputs and outputs on opposite sides of package allow easy interface with microprocessors
- Outputs source/sink 24 mA
- Faster prop delays than standard 'ACT573
- 4 kV minimum ESD immunity
- Standard Military Drawing (SMD)
  — 'ACTQ573: 5962-8766402

Ordering Code: See Section 8

Logic Symbols



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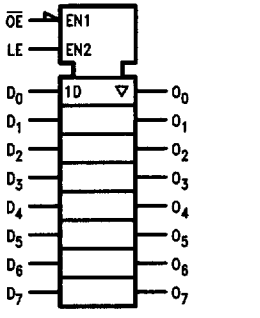
IEEE/IEC



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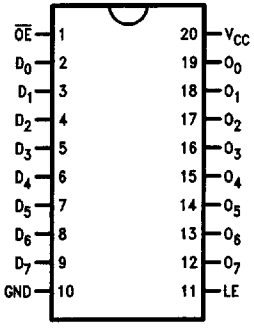
Connection Diagrams

Pin Assignment for DIP, Flatpak, QSOP and SOIC



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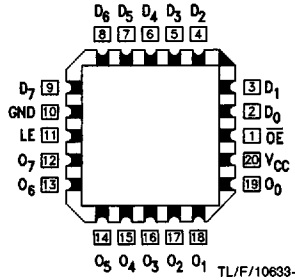
Pin Names	Description
D_0–D_7	Data Inputs
LE	Latch Enable Input
$\overline{OE}$	TRI-STATE Output Enable Input
O_0–O_7	TRI-STATE Latch Outputs

Pin Assignment for LCC



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Functional Description

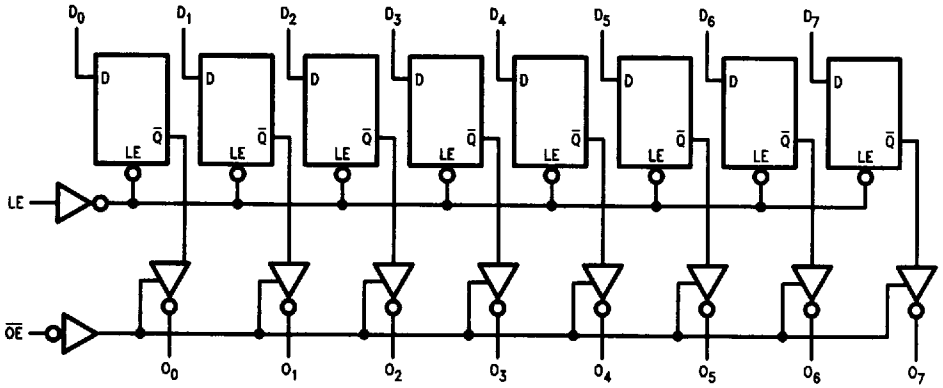
The 'ACQ/'ACTQ573 contains eight D-type latches with TRI-STATE output buffers. When the Latch Enable (LE) input is HIGH, data on the D_n inputs enters the latches. In this condition the latches are transparent, i.e., a latch output will change state each time its D input changes. When LE is LOW the latches store the information that was present on the D inputs a setup time preceding the HIGH-to-LOW transition of LE. The TRI-STATE buffers are controlled by the Output Enable ($\overline{OE}$) input. When $\overline{OE}$ is LOW, the buffers are enabled. When $\overline{OE}$ is HIGH the buffers are in the high impedance mode but this does not interfere with entering new data into the latches.

Truth Table

Inputs			Outputs
$\overline{OE}$	LE	D	O_n
L	H	H	H
L	H	L	L
L	L	X	O_0
H	X	X	Z

H = HIGH Voltage
L = LOW Voltage
Z = High Impedance
X = Immaterial
O_0 = Previous O_0 before HIGH-to-LOW transition of Latch Enable

Logic Diagram



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Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays

Absolute Maximum Rating (Note 1)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

Supply Voltage (V_{CC})	−0.5V to +7.0V
DC Input Diode Current (I_{IK})	
V_I = −0.5V	−20 mA
V_I = V_{CC} + 0.5V	+20 mA
DC Input Voltage (V_I)	−0.5V to V_{CC} + 0.5V
DC Output Diode Current (I_{OK})	
V_O = −0.5V	−20 mA
V_O = V_{CC} + 0.5V	+20 mA
DC Output Voltage (V_O)	−0.5V to V_{CC} + 0.5V
DC Output Source or Sink Current (I_O)	±50 mA
DC V_{CC} or Ground Current per Output Pin (I_{CC} or I_{GND})	±50 mA
Storage Temperature (T_{STG})	−65°C to +150°C
DC Latchup Source or Sink Current	±300 mA
Junction Temperature (T_J)	
CDIP	175°C
PDIP	140°C

Note 1: Absolute maximum ratings are those values beyond which damage to the device may occur. The databook specifications should be met, without exception, to ensure that the system design is reliable over its power supply, temperature, and output/input loading variables. National does not recommend operation of FACT™ circuits outside databook specifications.

Recommended Operating Conditions

Supply Voltage (V_{CC})	
'ACQ	2.0V to 6.0V
'ACTQ	4.5V to 5.5V
Input Voltage (V_I)	0V to V_{CC}
Output Voltage (V_O)	0V to V_{CC}
Operating Temperature (T_A)	
74ACQ/ACTQ	−40°C to +85°C
54ACQ/ACTQ	−55°C to +125°C
Minimum Input Edge Rate ΔV/Δt 'ACQ Devices V_{IN} from 30% to 70% of V_{CC} V_{CC} @ 3.0V, 4.5V, 5.5V	125 mV/ns
Minimum Input Edge Rate ΔV/Δt 'ACTQ Devices V_{IN} from 0.8V to 2.0V V_{CC} @ 4.5V, 5.5V	125 mV/ns

Note: All commercial packaging is not recommended for applications requiring greater than 2000 temperature cycles from −40°C to +125°C.

DC Characteristics for 'ACQ Family Devices

Symbol	Parameter	V_{CC} (V)	74ACQ T_A = +25°C		54ACQ T_A = −55°C to +125°C	74ACQ T_A = −40°C to +85°C	Units	Conditions
			Typ	Guaranteed Limits				
V_{IH}	Minimum High Level Input Voltage	3.0	1.5	2.1	2.1	2.1	V	V_{OUT} = 0.1V or V_{CC} − 0.1V
		4.5	2.25	3.15	3.15	3.15		
		5.5	2.75	3.85	3.85	3.85		
V_{IL}	Maximum Low Level Input Voltage	3.0	1.5	0.9	0.9	0.9	V	V_{OUT} = 0.1V or V_{CC} − 0.1V
		4.5	2.25	1.35	1.35	1.35		
		5.5	2.75	1.65	1.65	1.65		
V_{OH}	Minimum High Level Output Voltage	3.0	2.99	2.9	2.9	2.9	V	I_{OUT} = −50 μA
		4.5	4.49	4.4	4.4	4.4		
		5.5	5.49	5.4	5.4	5.4		
								*V_{IN} = V_{IL} or V_{IH}
		3.0		2.56	2.4	2.46		−12 mA
		4.5		3.86	3.7	3.76	V	I_{OH} −24 mA
		5.5		4.86	4.7	4.76		−24 mA
V_{OL}	Maximum Low Level Output Voltage	3.0	0.002	0.1	0.1	0.1	V	I_{OUT} = 50 μA
		4.5	0.001	0.1	0.1	0.1		
		5.5	0.001	0.1	0.1	0.1		
								*V_{IN} = V_{IL} or V_{IH}
		3.0		0.36	0.50	0.44		12 mA
		4.5		0.36	0.50	0.44	V	I_{OL} 24 mA
		5.5		0.36	0.50	0.44		24 mA

*All outputs loaded; thresholds on input associated with output under test.

DC Characteristics for 'ACQ Family Devices (Continued)

Symbol	Parameter	V_{CC} (V)	74ACQ $T_A = +25°C$	54ACQ $T_A = -55°C$ to $+125°C$	74ACQ $T_A = -40°C$ to $+85°C$	Units	Conditions
			Typ	Guaranteed Limits			
I_{IN}	Maximum Input Leakage Current	5.5		±0.1	±1.0	±1.0	μA	$V_I = V_{CC}$, GND (Note 1)
I_{OLD}	†Minimum Dynamic Output Current	5.5			50	75	mA	$V_{OLD} = 1.65\ V_{Max}$
I_{OHD}		5.5			−50	−75	mA	$V_{OHD} = 3.85\ V_{Min}$
I_{CC}	Maximum Quiescent Supply Current	5.5		4.0	80.0	40.0	μA	$V_{IN} = V_{CC}$ or GND (Note 1)
I_{OZ}	Maximum TRI-STATE Leakage Curent	5.5		±0.25	±5.0	±2.5	μA	$V_I(OE) = V_{IL}, V_{IH}$ $V_I = V_{CC}$, GND $V_O = V_{CC}$, GND
V_{OLP}	Quiet Output Maximum Dynamic V_{OL}	5.0	1.1	1.5			V	*Figures 2-12, 13* (Note 2, 3)
V_{OLV}	Quiet Output Minimum Dynamic V_{OL}	5.0	−0.6	−1.2			V	*Figures 2-12, 13* (Notes 2, 3)
V_{IHD}	Minimum High Level Dynamic Input Voltage	5.0	3.1	3.5			V	(Notes 2, 4)
V_{ILD}	Maximum Low Level Dynamic Input Voltage	5.0	1.9	1.5			V	(Notes 2, 4)

*All outputs loaded, thresholds on input associated with output under test.

†Maximum test duration 2.0 ms, one output loaded at a time

Note 1: I_{IN} and I_{CC} @ 3.0V are guaranteed to be less than or equal to the respective limit @ 5.5V V_{CC}. I_{CC} for 54ACQ @ 25°C is identical to 74ACQ @ 25°C.

Note 2: Plastic DIP package.

Note 3: Max number of outputs defined as (n) Data Inputs are driven 0V to 5V One output @ GND

Note 4: Max number of Data Inputs (n) switching (n − 1) Inputs switching 0V to 5V ('ACQ) Input-under-test switching: 5V to threshold (V_{ILD}), 0V to threshold (V_{IHD}), f = 1 MHz

DC Characteristics for 'ACTQ Family Devices

Symbol	Parameter	V_{CC} (V)	74ACTQ $T_A = +25°C$		54ACTQ $T_A = -55°C$ to $+125°C$	74ACTQ $T_A = -40°C$ to $+85°C$	Units	Conditions
			Typ	Guaranteed Limits				
V_{IH}	Minimum High Level Input Voltage	4.5 5.5	1.5 1.5	2.0 2.0	2.0 2.0	2.0 2.0	V	$V_{OUT} = 0.1V$ or $V_{CC} - 0.1V$
V_{IL}	Maximum Low Level Input Voltage	4.5 5.5	1.5 1.5	0.8 0.8	0.8 0.8	0.8 0.8	V	$V_{OUT} = 0.1V$ or $V_{CC} - 0.1V$
V_{OH}	Minimum High Level Output Voltage	4.5 5.5	4.49 5.49	4.4 5.4	4.4 5.4	4.4 5.4	V	$I_{OUT} = -50\ \mu A$
		4.5 5.5		3.86 4.86	3.70 4.70	3.76 4.76	V	*$V_{IN} = V_{IL}$ or V_{IH} I_{OH} −24 mA −24 mA
V_{OL}	Maximum Low Level Output Voltage	4.5 5.5	0.001 0.001	0.1 0.1	0.1 0.1	0.1 0.1	V	$I_{OUT} = 50\ \mu A$
		4.5 5.5		0.36 0.36	0.50 0.50	0.44 0.44	V	*$V_{IN} = V_{IL}$ or V_{IH} I_{OL} 24 mA 24 mA

*All outputs loaded, thresholds on input associated with output under test

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DC Characteristics for 'ACTQ Family Devices (Continued)

Symbol	Parameter	V_{CC} (V)	74ACTQ $T_A = +25°C$	54ACTQ $T_A = -55°C$ to $+125°C$	74ACTQ $T_A = -40°C$ to $+85°C$	Units	Conditions
			Typ	Guaranteed Limits			
I_{IN}	Maximum Input Leakage Current	5.5		±0.1	±1.0	±1.0	μA	$V_I = V_{CC}$, GND
I_{OZ}	Maximum TRI-STATE Leakage Current	5.5		±0.25	±5.0	±2.5	μA	$V_I = V_{IL}, V_{IH}$ $V_O = V_{CC}$, GND
I_{CCT}	Maximum I_{CC}/Input	5.5	0.6		1.6	1.5	mA	$V_I = V_{CC} - 2.1V$
I_{OLD}	†Minimum Dynamic Output Current	5.5			50	75	mA	V_{OLD} = 1.65V Max
I_{OHD}		5.5			−50	−75	mA	V_{OHD} = 3.85V Min
I_{CC}	Maximum Quiescent Supply Current	5.5		4.0	80.0	40.0	μA	$V_{IN} = V_{CC}$ or GND (Note 1)
V_{OLP}	Quiet Output Maximum Dynamic V_{OL}	5.0	1.1	1.5			V	*Figures 2-12, 13* (Notes 2, 3)
V_{OLV}	Quiet Output Minimum Dynamic V_{OL}	5.0	−0.6	−1.2			V	*Figures 2-12, 13* (Notes 2, 3)
V_{IHD}	Minimum High Level Dynamic Input Voltage	5.0	1.9	2.2			V	(Notes 2, 4)
V_{ILD}	Maximum Low Level Dynamic Input Voltage	5.0	1.2	0.8			V	(Notes 2, 4)

†Maximum test duration 2.0 ms, one output loaded at a time.

Note 1: I_{CC} for 54ACTQ @ 25°C is identical to 74ACTQ @ 25°C.

Note 2: Plastic DIP package.

Note 3: Max number of outputs defined as (n). Data Inputs are driven 0V to 3V. One output @ GND.

Note 4: Max number of data inputs (n) switching. (n − 1) inputs switching 0V to 3V ('ACTQ). Input-under-test switching: 3V to threshold (V_{ILD}), 0V to threshold (V_{IHD}), f = 1 MHz.

AC Electrical Characteristics: See Section 2 for Waveforms

Symbol	Parameter	V_{CC}* (V)	74ACQ $T_A = +25°C$, $C_L = 50$ pF			54ACQ $T_A = -55°C$ to $+125°C$, $C_L = 50$ pF		74ACQ $T_A = -40°C$ to $+85°C$, $C_L = 50$ pF		Units	Fig. No.
			Min	Typ	Max	Min	Max	Min	Max		
t_{PHL}, t_{PLH}	Propagation Delay D_n to O_n	3.3	2.5	8.5	10.5	1.5	16.0	2.5	11.0	ns	2-3, 4
		5.0	1.5	5.5	7.0	1.5	11.0	1.5	7.5		
t_{PLH}, t_{PHL}	Propagation Delay LE to O_n	3.3	2.5	8.5	12.0	1.5	15.0	2.5	12.5	ns	2-3, 4
		5.0	2.0	6.0	8.0	1.5	11.0	2.0	8.5		
t_{PZL}, t_{PZH}	Output Enable Time	3.3	2.5	8.5	13.0	1.5	13.5	2.5	13.5	ns	2-5, 6
		5.0	1.5	6.0	8.5	1.5	10.0	1.5	9.0		
t_{PHZ}, t_{PLZ}	Output Disable Time	3.3	1.0	9.0	14.5	1.5	13.0	1.0	15.0	ns	2-5, 6
		5.0	1.0	6.0	9.5	1.0	10.5	1.0	10.0		
t_{OSHL}, t_{OSLH}	Output to Output Skew** D_n to O_n	3.3		1.0	1.5				1.5	ns	
		5.0		0.5	1.0				1.0		

*Voltage Range 5.0 is 5.0V ±0.5V
Voltage Range 3.3 is 3.3V ±0.3V

**Skew is defined as the absolute value of the difference between the actual propagation delay for any two separate outputs of the same device. The specification applies to any outputs switching in the same direction, either HIGH to LOW (t_{OSHL} or LOW to HIGH (t_{OSLH}). Parameter guaranteed by design.

AC Operating Requirements: See Section 2 for Waveforms

Symbol	Parameter	V_{CC}* (V)	74ACQ $T_A = +25°C$, $C_L = 50$ pF		54ACQ $T_A = -55°C$ to $+125°C$, $C_L = 50$ pF	74ACQ $T_A = -40°C$ to $+85°C$, $C_L = 50$ pF	Units	Fig. No.
			Typ	Guaranteed Minimum				
t_S	Setup Time, HIGH or LOW D_n to LE	3.3	0	3.0	4.0	3.0	ns	2-7
		5.0	0	3.0	4.0	3.0		
t_H	Hold Time, HIGH or LOW D_n to LE	3.3	0	1.5	2.0	1.5	ns	2-7
		5.0	0	1.5	2.0	1.5		
t_W	LE Pulse Width, HIGH	3.3	2.0	4.0	5.0	4.0	ns	2-4
		5.0	2.0	4.0	5.0	4.0		

*Voltage Range 5 0 is 5 0V ±0 5V
Voltage Range 3 3 is 3 3V ±0 3V

AC Electrical Characteristics: See Section 2 for Waveforms

Symbol	Parameter	V_{CC}* (V)	74ACTQ $T_A = +25°C$, $C_L = 50$ pF			54ACTQ $T_A = -55°C$ to $+125°C$, $C_L = 50$ pF		74ACTQ $T_A = -40°C$ to $+85°C$, $C_L = 50$ pF		Units	Fig. No.
			Min	Typ	Max	Min	Max	Min	Max		
t_{PHL}, t_{PLH}	Propagation Delay D_n to O_n	5.0	2.0	6.5	7.5	1.5	10.0	2.0	8.0	ns	2-3, 4
t_{PLH}, t_{PHL}	Propagation Delay LE to O_n	5.0	2.5	7.0	8.5	1.5	11.0	2.5	9.0	ns	2-3, 4
t_{PZL}, t_{PZH}	Output Enable Time	5.0	2.0	7.0	9.0	1.5	11.0	2.0	9.5	ns	2-5, 6
t_{PHZ}, t_{PLZ}	Output Disable Time	5.0	1.0	8.0	10.0	1.5	11.0	1.0	10.5	ns	2-5, 6
t_{OSHL} t_{OSLH}	Output to Output Skew** D_n to O_n	5.0		0.5	1.0				1.0	ns	

*Voltage Range 5 0 is 5 0V ±0.5V

**Skew is defined as the absolute value of the difference between the actual propagation delay for any two separate outputs of the same device The specification applies to any outputs switching in the same direction, either HIGH to LOW (t_{OSHL} or LOW to HIGH (t_{OSLH}) Parameter guaranteed by design

AC Operating Requirements: See Section 2 for Waveforms

Symbol	Parameter	V_{CC}* (V)	74ACTQ $T_A = +25°C$, $C_L = 50$ pF		54ACTQ $T_A = -55°C$ to $+125°C$, $C_L = 50$ pF	74ACTQ $T_A = -40°C$ to $+85°C$, $C_L = 50$ pF	Units	Fig. No.
			Typ	Guaranteed Minimum				
t_S	Setup Time, HIGH or LOW D_n to LE	5.0	0	3.0	3.5	3.0	ns	2-7
t_H	Hold Time, HIGH or LOW D_n to LE	5.0	0	1.5	1.5	1.5	ns	2-7
t_W	LE Pulse Width, HIGH	5.0	2.0	4.0	5.0	4.0	ns	2-4

*Voltage Range 5 0 is 5 0V ±0 5V

Capacitance

Symbol	Parameter	Typ	Units	Conditions
C_{IN}	Input Capacitance	4.5	pF	V_{CC} = OPEN
C_{PD}	Power Dissipation Capacitance	42.0	pF	V_{CC} = 5.0V